Notice of References Cited Application/Control No. 10/534,488 Examiner Dimple N. Bodawala Applicant(s)/Patent Under Reexamination INADA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,472,334 A	12-1995	Takahashi, Mitsuo	425/554
*	В	US-5,607,705 A	03-1997	Asai, Ikuo	425/190
*	С	US-5,820,898 A	10-1998	Yasuda, Katsuyuki	425/542
*	D	US-6,971,866 B2	12-2005	Ebina et al.	. 425/192R
	E	US			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	Ļ	US-			·
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	. Name	Classification
	N					
	0					
	Р					
	q					
	R					
	Ø					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	v	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.